

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination PUNIELLO ET AL.	
		Examiner EDMUND H. LEE	Art Unit 1732	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,022,279	02-2000	Yamagishi et al.	473/353
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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